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|-----------------------------------|--|---------------------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. 10/663,519 | Applicant(s)/Patent Under Reexamination KINNARD ET AL. | |
| | | Examiner James Keenan | Art Unit 3652 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-5,151,008 | 09-1992 | Ishida et al. | 414/744.5 |
| | B | US-5,851,296 | 12-1998 | Haraguchi et al. | 118/719 |
| | C | US-6,190,114 | 02-2001 | Ogawa et al. | 414/744.5 |
| | D | US-6,293,746 | 09-2001 | Ogawa et al. | 414/744.4 |
| | E | US-6,499,936 | 12-2002 | Ishigame, Tooru | 414/744.5 |
| | F | US-6,547,510 | 04-2003 | Beaulieu, David R. | 414/744.5 |
| | G | US-6,558,107 | 05-2003 | Okuno, Chohei | 414/744.5 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
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NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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